



ALTERNATIVE TO PTO/SB/08/B (04/07)

<b>INFORMATION DISCLOSURE STATEMENT BY APPLICANT</b> (Use as many sheets as necessary)				<b>Complete if Known</b>	
				Application Number	10/727,696
Sheet 1 of 1				Filing Date	December 3, 2003
				First Named Inventor	Chaitan KHOSLA
				Art Unit	1656
				Examiner Name	<del>N. T. Noched</del> Alexander Kim
				Attorney Docket Number	300622000508

U.S. PATENT DOCUMENTS					
Examiner Initials*	Cite No. <sup>1</sup>	Document Number	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
		Number-Kind Code <sup>2</sup> (if known)			
	1.	US-5,098,837	03-24-1992	Beckmann et al.	
	2.	US-5,149,639	09-22-1992	Katz et al.	
	3.	US-5,252,474	10/1993	Gewain et al.	
	4.	US-6,060,234	05/2000	Katz et al.	

FOREIGN PATENT DOCUMENTS					
Examiner Initials*	Cite No. <sup>1</sup>	Foreign Patent Document	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
		Country Code <sup>3</sup> -Number <sup>4</sup> -Kind Code <sup>5</sup> (if known)			

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NON PATENT LITERATURE DOCUMENTS					
Examiner Initials	Cite No. <sup>1</sup>	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.			T <sup>2</sup>
	5.	BEDFORD et al., Chemistry and Biology (1996) 3:827-831			
	6.	BROWN et al., J. Chem. Soc. Chem. Commun. (1995) 15:1517-1518			
	7.	DONADIO et al., Gene (1992) 115:97-103			
	8.	DONADIO et al., Industrial Microorganism, Basic and Applied Molecular Genetics, R. H. Baltz, G. D. Hegeman and P.L. Skatrud (eds.), Amer. Soc. Microbial., Washington D.C., 1993, pages 251-266			
	9.	DONADIO et al., Proc. Natl. Acad. Sci. USA (1993) 90:7119-7123			
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	11.	HUTCHINSON, Bio/Technology (1994) 12:375-380			
	12.	KHOSLA et al., Tibtech (1996) 14:335-341			
	13.	LIU et al., JACS (1997) 119:10553-10554			
	14.	MACNEIL et al., Gene (1992) 115:119-125			
	15.	MACNEIL et al., Industrial Microorganisms: Basic and Applied Molecular Genetics (1993) 30:245-256			
	16.	MARSDEN et al., Science (1998) 279:199-202			
	17.	MCALPINE et al., The Journal of Antibiotics (1987) 40(8):1115-1122			
	18.	ROHR, Chem. Int. Ed. Engl. (1995) 34(8):881-886			
	19.	RUAN et al., J. of Bacteriology (1997) 79(20):6416-6425			
	20.	STASSI et al., PNAS (1998) 95:7305-7309			

Examiner Signature	/Alexander Kim/	Date Considered	06/23/2008
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sd-394990 REFERENCES CONSIDERED EXCEPT WHERE LINED THROUGH. /AK/